

RENESAS 2.5V Single Data Rate 1:10 Clock Buffer Terabuffer™ Jr.

PRODUCT DISCONTINUATION NOTICE - LAST TIME BUY EXPIRES SEPTEMBER 7, 2016 DATASHEET

FEATURES:

- · Optimized for 2.5V LVTTL
- Guaranteed Low Skew < 125ps (max)
- Very low duty cycle distortion < 300ps (max)
- High speed propagation delay < 2ns. (max)
- Up to 200MHz operation
- · Very low CMOS power levels
- · Hot insertable and over-voltage tolerant inputs
- 1:10 fanout buffer
- 2.5V VDD
- Available in TSSOP package
- NOT RECOMMENDED FOR NEW DESIGNS
- For replacement part use 8T39S11

APPLICATIONS:

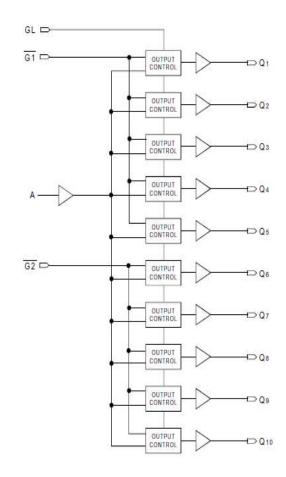
· Clock and signal distribution

DESCRIPTION:

The 5t9070 2.5V single data rate (SDR) clock buffer is a single-ended input to ten single-ended outputs buffer built on advanced metal CMOS technology. The SDR clock buffer fanout from a single input to ten single-ended outputs reduces the loading on the preceding driver and provides an efficient clock distribution network.

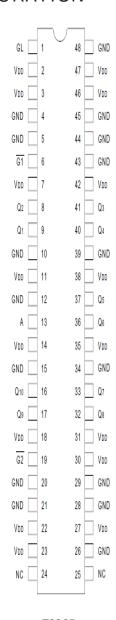
The 5t9070 has two output banks that can be asynchronously enabled/ disabled. Multiple power and grounds reduce noise.

FUNCTIONAL BLOCK DIAGRAM





PIN CONFIGURATION



TSSOP TOP VIEW

ABSOLUTE MAXIMUM RATINGS(1)

Symbol	Description	Max	Unit
VDD	Power Supply Voltage	-0.5 to +3.6	V
Vı	Input Voltage	-0.5 to +3.6	V
Vo	Output Voltage	-0.5 to VDD +0.5	V
Tstg	Storage Temperature	-65 to +165	°C
TJ	Junction Temperature	150	°C

NOTE:

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

$CAPACITANCE^{(1)}$ (TA = +25°C, F = 1.0MHz)

Symbol	Parameter	Min	Tvp.	Max.	Unit
CIN	Input Capacitance		6		pF

NOTE:

1. This parameter is measured at characterization but not tested.

RECOMMENDED OPERATING RANGE

Svmbol	Description	Min.	Tvp.	Max.	Unit
TA	Ambient Operating Temperature	-40	+25	+85	°C
VDD	Internal Power Supply Voltage	2.3	2.5	2.7	V



PIN DESCRIPTION

Symbol	I/O	Type	Description
Α		LVTTL	Clock input
G1	I	LVTTL	Gate for outputs Q ₁ through Q ₅ . When $\overline{G1}$ is LOW, these outputs are enabled. When $\overline{G1}$ is HIGH, these outputs are asynchronously disabled to the level designated by $GL^{(1)}$.
G2	I	LVTTL	Gate for outputs Q6 through Q10. When $\overline{G2}$ is LOW, these outputs are enabled. When $\overline{G2}$ is HIGH, these outputs are asynchronously disabled to the level designated by $GL^{(1)}$.
GL		LVTTL	Specifies output disable level. If HIGH, the outputs disable HIGH. If LOW, the outputs disable LOW.
Qn	0	LVTTL	Clock outputs
VDD		PWR	Power supply for the device core, inputs, and outputs
GND		PWR	Power supply return for power

NOTE:

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE (1)

Symbol	Parameter	Test Conditions	Min.	Тур.(4)	Max	Unit
Іін	Input HIGH Current	V _{DD} = 2.7V V _I = V _{DD} /GND			±5	μΑ
lıL	Input LOW Current	V _{DD} = 2.7V V _I = GND/V _{DD}		_	±5	
Vıĸ	Clamp Diode Voltage	V _{DD} = 2.3V, I _{IN} = -18mA		- 0.7	- 1.2	V
Vin	DC Input Voltage		- 0.3		+3.6	V
VIH	DC Input HIGH ⁽²⁾		1.7			V
VIL	DC Input LOW(3)				0.7	V
Vон	Output HIGH Voltage	loн = -12mA	V _{DD} - 0.4			V
		loн = -100 u A	Vpp - 0.1			V
Vol	Output LOW Voltage	lo _L = 12mA	_		0.4	V
	-	lol = 100μA	_		0.1	V

NOTES:

- 1. See RECOMMENDED OPERATING RANGE table.
- 2. Voltage required to maintain a logic HIGH.
- 3. Voltage required to maintain a logic LOW.
- 4. Typical values are at $V_{DD} = 2.5V$, $+25^{\circ}C$ ambient.

^{1.} Because the gate controls are asynchronous, runt pulses are possible. It is the user's responsibility to either time the gate control signals to minimize the possibility of runt pulses or be able to tolerate them in down stream circuitry.



POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions ⁽¹⁾	Typ.	Max	Unit
IDDQ	Quiescent VDD Power Supply Current VDD = Max., Reference Clock = LOW		1.5	2	mA
		Outputs enabled, All outputs unloaded			
IDDD	Dynamic Vdd Power Supply	VDD = Max., VDD = Max., CL = 0pF	150	200	μΑ/MHz
	Current per Output				
Ітот	Total Power VDD Supply Current	VDD = 2.5V., FREFERENCE CLOCK = 100MHz, CL = 15pF	70	90	mA
		VDD = 2.5V., FREFERENCE CLOCK = 200MHz, CL = 15pF	100	150	

NOTE:

INPUT AC TEST CONDITIONS

Symbol	Parameter	Value	Units
VIH	Input HIGH Voltage	V _{DD}	V
VIL	Input LOW Voltage	0	V
VTH	Input Timing Measurement Reference Level ⁽¹⁾	V _{DD} /2	V
tr, tr	Input Signal Edge Rate ⁽²⁾	2	V/ns

NOTES:

- 1. A nominal 1.25V timing measurement reference level is specified to allow constant, repeatable results in an automatic test equipment (ATE) environment.
- $2. \ \, \text{The input signal edge rate of 2V/ns or greater is to be maintained in the 10\% to 90\% range of the input waveform.}$

AC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE(4)

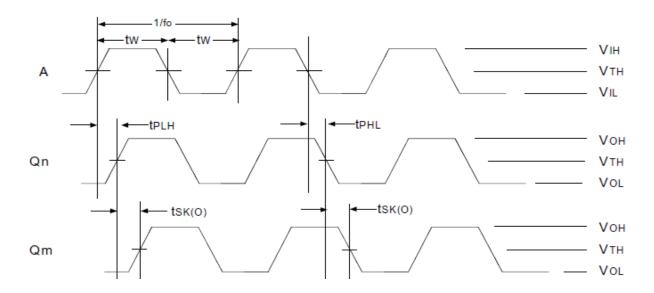
Symbol	Parameter	Min.	Тур.	Max	Unit
Skew Parameters					
tsk(o)	Same Device Output Pin-to-Pin Skew ⁽¹⁾		_	125	ps
tsk(p)	Pulse Skew ⁽²⁾			300	ps
tsk(PP)	Part-to-Part Skew ⁽³⁾	–	_	300	ps
Propagation Dela	ıy	•			
t PLH	Propagation Delay A to Qn		_	2	ns
<u>tphl</u>					
tr	Output Rise Time (20% to 80%)	350	_	850	ps
tF	Output Fall Time (20% to 80%)	350		850	ps
fo	Frequency Range	_	_	200	MHz
Output Gate Enab	ole/Disable Delay		•		
tpge	Output Gate Enable to On	_		3.5	ns
tPGD	Output Gate Enable to Qn Driven to GL Designated Level	_	_	3	ns

- NOTES:
- 1. Skew measured between all outputs under identical input and output transitions and load conditions on any one device.
- 2. Skew measured is the difference between propagation delay times that and then of any output under identical input and output transitions and load conditions on any one device.
- 3. Skew measured is the magnitude of the difference in propagation times between any outputs of two devices, given identical transitions and load conditions at identical VDD levels and temperature.
- 4. Guaranteed by design.

^{1.} The termination resistors are excluded from these measurements.



AC TIMING WAVEFORMS

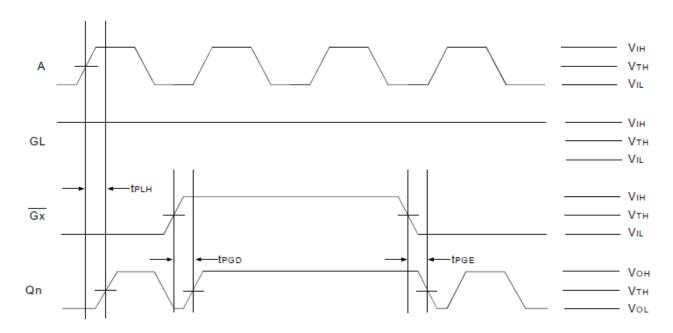


Propagation and Skew Waveforms

NOTE: Pulse Skew is calculated using the following expression:

$$tsk(P) = |tPHL - tPLH|$$

where tphl and tplh are measured on the controlled edges of any one output from rising and falling edges of a single pulse. Please note that the tphl and tplh shown are not valid measurements for this calculation because they are not taken from the same pulse.



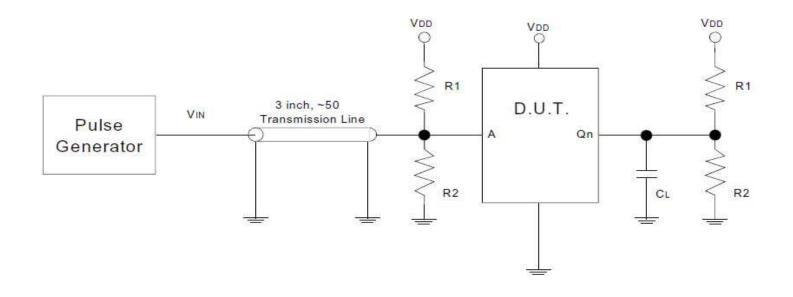
Gate Disable/Enable Runt Pulse Generation

NOTE:

As shown, it is possible to generate runt pulses on gate disable and enable of the outputs. It is the user's responsibility to time their \overline{Gx} signals to avoid this problem.



TEST CIRCUIT AND CONDITIONS



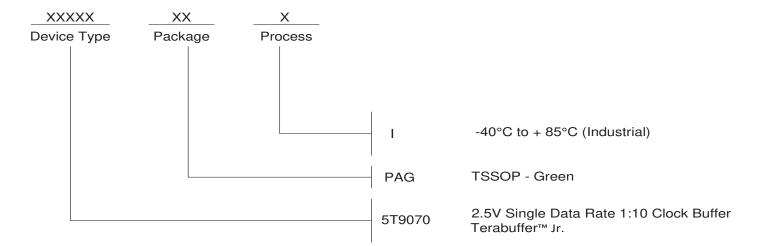
Test Circuit for Input/Output

INPUT/OUTPUT TEST CONDITIONS

Svmbol	$V_{DD} = 2.5V \pm 0.2V$	Unit
VTH	V _{DD} / 2	V
R1	100	Ω
R2	100	Ω
CL	15	pF



ORDERING INFORMATION





REVISION HISTORY

Rev	Table	Page	Discription of Change	Date
Α		1	NRND - Not Recommended for New Designs	5/5/13
А		7	Ordering Information - removed PA leaded device Updated datsheet format	4/14/15
Α		1	Product Discontinuation Notice - Last Time Buy Expires September 7, 2016. PDN# N-16-02.	3/10/16



IMPORTANT NOTICE AND DISCLAIMER

RENESAS ELECTRONICS CORPORATION AND ITS SUBSIDIARIES ("RENESAS") PROVIDES TECHNICAL SPECIFICATIONS AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS OR IMPLIED, INCLUDING, WITHOUT LIMITATION, ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for developers skilled in the art designing with Renesas products. You are solely responsible for (1) selecting the appropriate products for your application, (2) designing, validating, and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. Renesas grants you permission to use these resources only for development of an application that uses Renesas products. Other reproduction or use of these resources is strictly prohibited. No license is granted to any other Renesas intellectual property or to any third party intellectual property. Renesas disclaims responsibility for, and you will fully indemnify Renesas and its representatives against, any claims, damages, costs, losses, or liabilities arising out of your use of these resources. Renesas' products are provided only subject to Renesas' Terms and Conditions of Sale or other applicable terms agreed to in writing. No use o any Renesas resources expands or otherwise alters any applicable warranties or warranty disclaimers for these products.

(Disclaimer Rev.1.0 Mar 2020)

Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu, Koto-ku, Tokyo 135-0061, Japan www.renesas.com

Trademarks

Renesas and the Renesas logo are trademarks of Renesas Electronics Corporation. All trademarks and registered trademarks are the property of their respective owners.

Contact Information

For further information on a product, technology, the most up-to-date version of a document, or your nearest sales office, please visit:

www.renesas.com/contact/